

Notice of References Cited	Application/Control No. 10/672,919	Applicant(s)/Patent Under Reexamination YEDIDIA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0037298 A1	02-2003	Eleftheriou et al.	714/752
*	B	US-2003/0033570 A1	02-2003	Khannanov et al.	714/755
*	C	US-2003/0065989 A1	04-2003	Yedida et al.	714/703
*	D	US-2003/0074626 A1	04-2003	Coker et al.	714/752
*	E	US-2003/0079171 A1	04-2003	Coe, Tim	714/758
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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